

# Ground effect analysis of open field test site for EMI

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## ABSTRACT

The thesis is dedicated to the analysis of electromagnetic effects caused by the metal grounding of open area test site (OATS) for EMI measurement. Due to the strong relationship between the normal site attenuation (NSA) performance versus electromagnetic reflection and diffraction effects introduced by the dimension and discontinuous edges of metal ground, therefore the thesis is focused on the investigation of ground plane configuration effect and the comparison of numerical analysis and experimental measurements. To analyze the influences of ground plane dimension and its edge diffraction on the NSA, and therefore the compensation techniques (such as extending metal plane at some locations, adding metal meshes on edges with slant angles), we utilized the numerical methods FDTD and GTD to establish the diffraction models for 30- 200 MHz and 200-1000 MHz frequency ranges respectively. With the investigation of numerical model for OATS with finite ground plane and verification by the measured data, we can further improve the NSA performance to meet the stringent requirement of international standards and regulations for the EMI open area test sites.

Keywords : Electromagnetic Interference (EMI) ; Open Area Test Site (OATS) ; Edge Diffraction ; Normalized Site Attenuation (NSA) ; Finite-Difference Time- Domain (FDTD) ; High Frequency Technique

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## REFERENCES

- [1] CISPR 16-1. " Specification for Radio Disturbance and Immunity Apparatus and Methods ", 1993.
- [2] ANSI C63.4-1992, " American National Standard : Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electric and Electronic Equipment in the Range of 9KHz to 40 GHz. ", 1992.
- [3] ANSI C63.7-1992. " American National Standard Guide for Construction of Open-Area Test Site for Performing Radiated Emission Measurements. ", 1992.
- [4] ANSI C63.7-1992, " American National Standard for Methods of Measurement of Radio-Noise Emissions from Low Voltage Electrical and Electric Equipment in the range of 9 kHz to 40 GHz " [5] A. Smith, R. F. German, and J. B. Pate, " Calculation of Site Attenuation From Antenna Factors. " IEEE Transactions on Electromagnetic Compatibility , Vol. EMC-24, No. 3, pp. 301-316 August 1982.
- [6] Federal Communications Commission, " Calibration of a radiation measurement site — Site Attenuation. " Appendix A.
- [7] W. Mullner, and A. Kriz, " Site Attenuation of Limited-Size Ground Planes For Vertical Polarisation ", IEEE International Symp. EMC, pp. 341-346 2001. ZURICH.
- [8] Constantine A. Balanis, " Antenna Theory Analysis and Design ", Wiley, New York, 1997, 2nd.
- [9] W. Scott Bennett, " Normalized site attenuation newly characterized ", IEEE Int. Symp. Electromag. Compat., Vol.1, pp.141-146, 1998.
- [10] Yee, K. S., " Numerical solution of initial boundary value problems involving Maxwell ' s equations in isotropic media, " IEEE Trans.

Antennas and Propagat., vol. 14, pp.302-307, 1966.

[11]Navarro, E. A., N. T. Sangary, and J. Litva, " Some considerations on the accuracy of the non-uniform FDTD method and its application to waveguide analysis when combined with the perfectly matched layer technique, " IEEE Trans. Microwave Theory Tech., vol. 44, pp. 1115-1124, July 1996.

[12]Okoniewski, Michal., E. Okoniewska, and M. A. Stuchly, " Three-dimensional subgridding algorithm for FDTD, " IEEE Trans. Antennas and Propagat., vol. 45, pp. 422-429, Mar. 1997.

[13]Jurgens, T. G., and A. Taflove, " Three-Dimensional Contour FDTD Modeling of Scattering from Single and Multiple Bodies, " IEEE Trans. Antennas Propagat., vol. 41, pp. 1703-1708, Dec. 1993.

[14]Mur, G., " Absorbing boundary conditions for the finite-difference approximation of the time-domain electromagnetic field equations, " IEEE Trans. Electromagnetic Compatibility, vol. EMC-23, pp. 377-382, Nov. 1981.

[15]Berenger, J., " A perfectly matched layer for the absorption of electromagnetic waves, " J. Computat. Phys., vol. 114, pp. 185-200, 1994.

[16]Sacks, Z.S., D.M. Kingsland, R. Lee, and J. F. Lee, " A perfectly matched anisotropic absorber for use as an absorbing boundary condition, " IEEE Trans. Antennas and Propagat., vol. 43, pp. 1460 —1463, Dec. 1995.

[17]A. K. Bhattacharyya, " High-Frequency Electromagnetic Techniques Recent Advances and Applications " , John Wiley & Sons, USA, 1995.

[18]Derek A. McNamara, Carl W.I. Pistorius, and J. A. G. Malherbe, " Introduction to the Uniform Geometrical Theory of Diffraction " , Artech House, Boston, 1990.

[19]謝翰璋, " 有限金屬平面對正規化場地衰減之影響 " ,台灣大學.

[20]I. Anderson, " Wave diffraction by a thin dielectric half-plane, " IEEE Trans. Antennas Propagat., vol. AP-27, pp. 584-589, May 1976.

[21]Arslan Yazici, and A. Hamit Serbest, " Scattering of plane waves by an Anisotropic Dielectric half-plane, " IEEE Trans. Antennas Propagat., vol.47, pp. 1476-1484, 1999.

[22]陳茂元 " Ray Analysis of EMC Fully Anechoic Chamber " , 大葉大學.

[23]D. K. Cheng, " Fundamentals of Engineering Electromagnetics " , by Addison Wesley.

[24]Jin Au Kong, " Electromagnetic Wave Theory " , by John Wiley & Sons Ltd, 1986.

[25]V. P. Kodali, " Engineering Electromagnetic Compatibility, Principles, Measurements, and Technologies. " IEEE press, New York, 1996.

[26]McConnell, R.A.; Vitek, C. " OATS measurements " CKC Lab. Inc., Mariposa, CA, USA [27]Tesche, F.M.; Ianoz, M.V.; Karlsson, T. " EMC analysis methods and computational models " , John Wiley & Sons Ltd.